Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/017,554	PARK ET AL.	
Examiner	Art Unit	
Binh Q. Nguyen	2664	

SEARCHED				
Class	Subclass	Date	Examiner	
370	310.1 310.2	8/11/2005	BQN	
370	332	8/12/2005	BQN	
370	329	8/11/2005	BQN	
370	328	8/11/2005	BQN	
370	335	8/11/2005	BQN	
370	342	8/15/2005	BQN	
370	352	8/11/2005	BQN	
455	550.1	8/11/2005	BQN	
455	435.2	8/15/2005	BQN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)- See Search History Printout	8/11/2005	BQN
EAST, consulted Wellinton Chin	8/15/2005	ВОМ
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